## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | CHONG ET AL. | Examiner | Art Unit | Vincent T. Tran | 2115 | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,978,281	11-1999	Anand et al.	365/189.05
*	В	US-2001/0004335	06-2001	Murakami, Naoki	365/233
*	U	US-6,509,776	01-2003	Kobayashi et al.	327/277
*	ם	US-6,316,980	11-2001	Vogt et al.	327/273
*	Е	US-6,279,073	08-2001	McCracken et al.	711/105
*	F	US-6,940,768	09-2005	Dahlberg et al.	365/201
*	G	US-2001/0046163	11-2001	Yanagawa, Miki	365/194
*	Η	US-6,492,852	12-2002	Fiscus, Timothy E.	327/158
*	ı	US-6,212,113	04-2001	Maeda, Kazunori	365/201
*	7	US-6,295,245	09-2001	Tomita et al.	365/230.08
*	K	US-6,525,585	02-2003	lida et al.	327/279
*	L	US-6,212,127	04-2001	Funaba et al.	365/233
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.